

Notice of References Cited	Application/Control No. 10/626,766	Applicant(s)/Patent Under Reexamination KWON ET AL.	
	Examiner Terry D. Cunningham	Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,765,428	07-2004	Kim et al.	327/534
	B	US-6,552,600	04-2003	Walimbe et al.	327/536
	C	US-6,507,237	01-2003	Hsu et al.	327/538
	D	US-6,498,761	12-2002	Banba et al.	365/226
	E	US-6,429,725	08-2002	Tanzawa et al.	327/536
	F	US-6,414,881	07-2002	Fujii et al.	365/189.09
	G	US-6,356,499	03-2002	Banba et al.	365/226
	H	US-6,275,096	08-2001	Hsu et al.	327/535
	I	US-6,128,242	10-2000	Banba et al.	365/226
	J	US-6,052,022	04-2000	Lee, Chul-Kyu	327/589
	K	US-5,929,693	07-1999	Kuroda, Tadahiro	327/535
	L	US-5,337,284	08-1994	Cordoba et al.	327/540
	M	US-2002/0084833	07-2002	Kim et al.	327/536

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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